


<b>Search Notes</b> 	<b>Application/Control No.</b> 10055499	<b>Applicant(s)/Patent Under Reexamination</b> LEE ET AL.
	<b>Examiner</b> Thai, Luan	<b>Art Unit</b> 2891

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search updated	11/21/07	LT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner